



## 18. TEST PHOTOGRAPHS

See following Attached Pages for setup photographs.

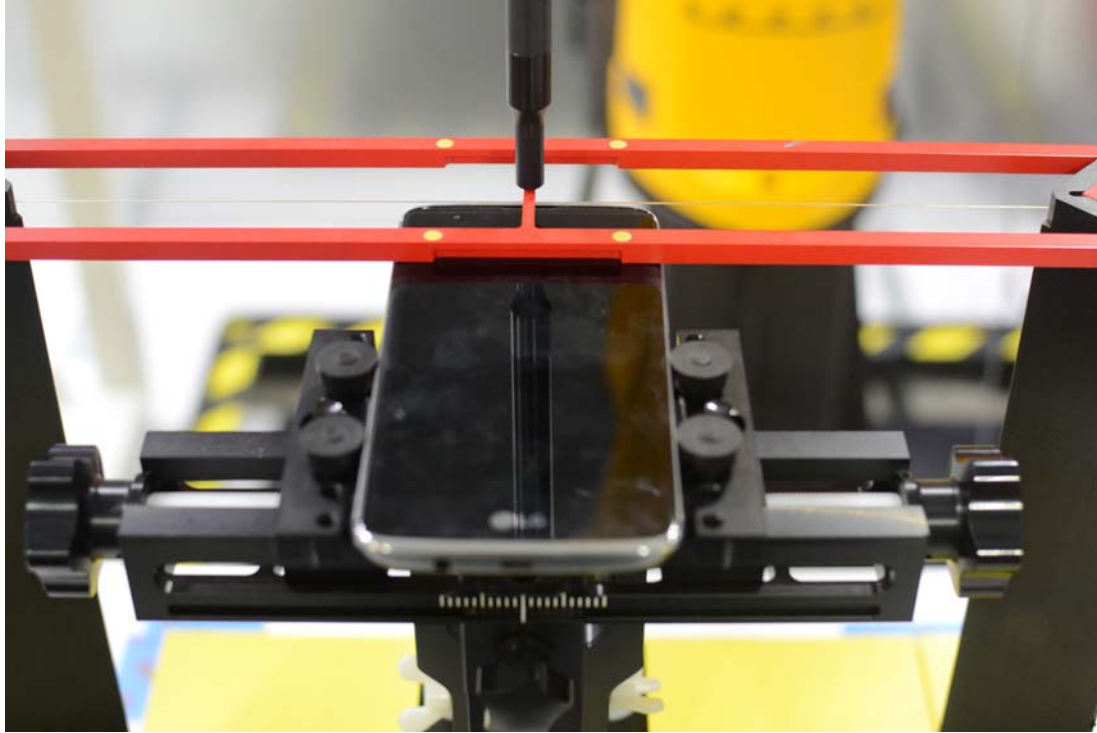
<b>FCC ID:</b> ZNFK330	 <b>PCTEST</b> ENGINEERING LABORATORY, INC.	<b>HAC (RF EMISSIONS) TEST REPORT</b>	 <b>LG</b>	<b>Reviewed by:</b> Quality Manager
<b>Filename:</b> 0Y1511161964-R1.ZNF	<b>Test Dates:</b> 11/16/2015 - 11/18/2015	<b>EUT Type:</b> Portable Handset	Page 76 of 78	

© 2015 PCTEST Engineering Laboratory, Inc.

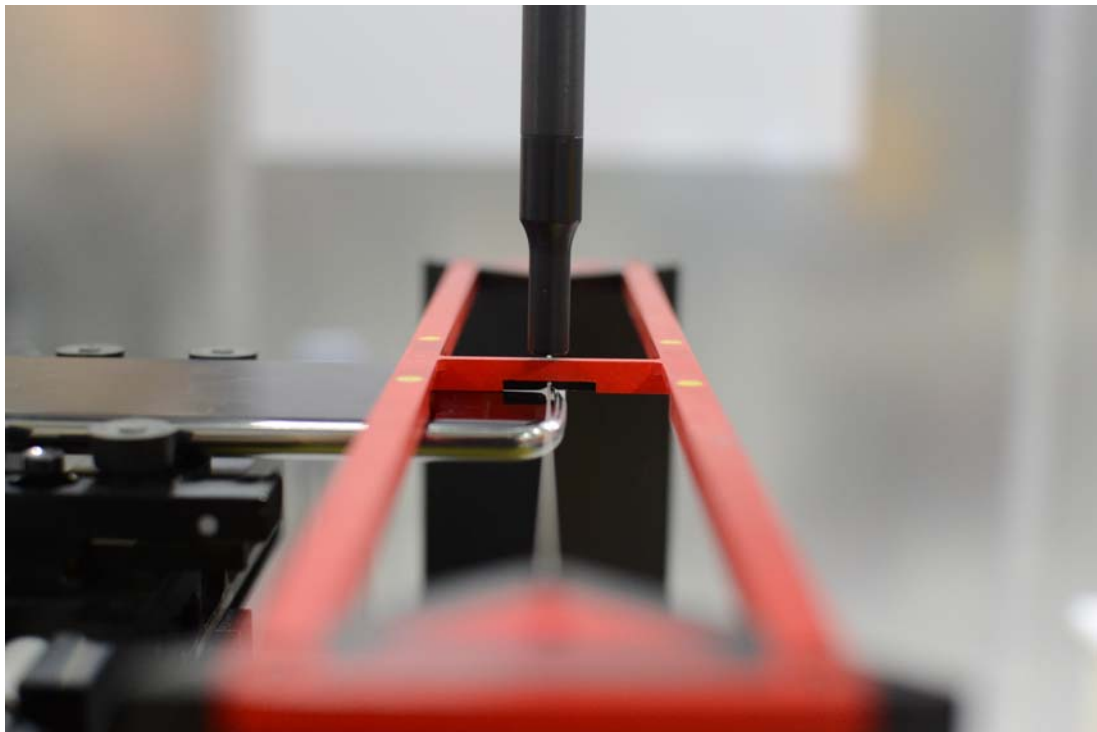
REV 3.1.M

09/23/2015



© 2015 PCTEST Engineering Laboratory, Inc. All rights reserved. Unless otherwise specified, no part of this report may be reproduced or utilized in any part, form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from PCTEST Engineering Laboratory, Inc. If you have any questions about this international copyright or have an enquiry about obtaining additional rights to this report or assembly of contents thereof, please contact [INFO@PCTESTLAB.COM](mailto:INFO@PCTESTLAB.COM).



**Figure 18-1**  
**Ear Reference Point HAC Phantom Alignment**



**Figure 18-2**  
**HAC Phantom Plane Alignment**

FCC ID: ZNFK330	 PCTEST ENGINEERING LABORATORY, INC.	HAC (RF EMISSIONS) TEST REPORT	 LG	Reviewed by: Quality Manager
Filename: 0Y1511161964-R1.ZNF	Test Dates: 11/16/2015 - 11/18/2015	EUT Type: Portable Handset		Page 77 of 78

© 2015 PCTEST Engineering Laboratory, Inc.

REV 3.1.M

09/23/2015

© 2015 PCTEST Engineering Laboratory, Inc. All rights reserved. Unless otherwise specified, no part of this report may be reproduced or utilized in any part, form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from PCTEST Engineering Laboratory, Inc. If you have any questions about this international copyright or have an enquiry about obtaining additional rights to this report or assembly of contents thereof, please contact [INFO@PCTESTLAB.COM](mailto:INFO@PCTESTLAB.COM).

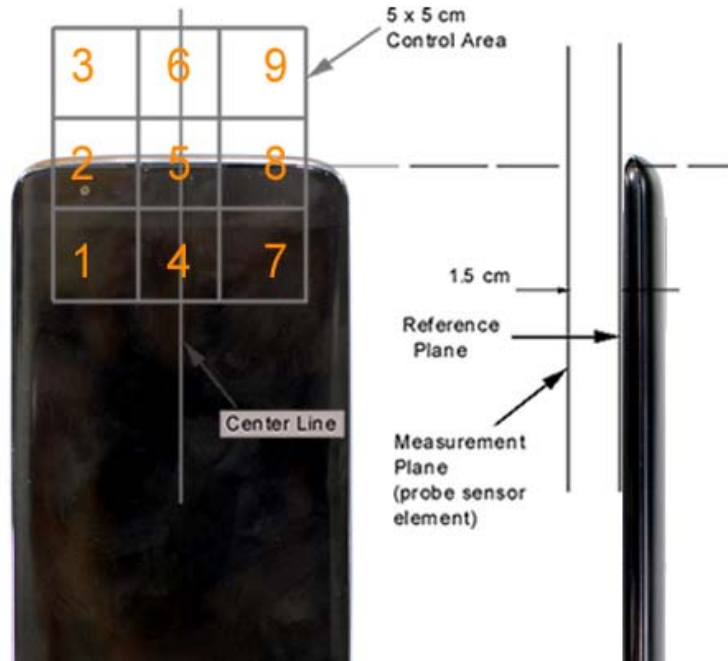


Figure 18-3 5x5 Scan grid above WD



Figure 18-4 E-Field WD Scan overlay

FCC ID: ZNFK330	PCTEST ENGINEERING LABORATORY, INC.	HAC (RF EMISSIONS) TEST REPORT	LG	Reviewed by: Quality Manager
Filename: 0Y1511161964-R1.ZNF	Test Dates: 11/16/2015 - 11/18/2015	EUT Type: Portable Handset		Page 78 of 78